



ANALOG DEVICES Fast, Complete 12-Bit Sampling A/D Converter with Microprocessor Interface

AD1674

1.1 Scope.

This specification covers the detail requirements for a 12-bit resolution sampling A/D converter with complete microprocessor interface and a high performance reference.

1.2 Part Number.

The complete part number per Table 1 of this specification is as follows:

Device	Part Number ¹
- 1	AD1674T(X)/883B

NOTE

¹See paragraph 1.2.3 for package identifier.

1.2.3 Case Outline.

See Appendix 1 of General Specification ADI-M-1000: package outline:

(X)	Package	Description
D	D-28	28-Pin Ceramic DIP

1.3 Absolute Maximum Ratings. ($T_A = +25^\circ\text{C}$ unless otherwise noted)

V_{CC} to Digital Common	+16.5 V
V_{EE} to Digital Common	-16.5 V
V_{LOGIC} to Digital Common	+7 V
Analog Common to Digital Common	± 1 V
Control Inputs (CE, \overline{CS} , A_0 , $12/\overline{8}$, R/\overline{C}) to Digital Common	-0.5 V to $V_{LOGIC} + 0.5$ V
Analog Inputs (REF IN, BIP OFF, $10 V_{IN}$) to Analog Common	V_{EE} to V_{CC}
$20 V_{IN}$ to Analog Common	V_{EE} to +24 V
REF OUT	Indefinite Short to Common Momentary Short to V_{CC}
Power Dissipation	825 mW
Storage Temperature Range	-65°C to +150°C
Lead Temperature (Soldering 10 sec)	+300°C

1.5 Thermal Characteristics.

Thermal Resistance $\theta_{JC} = 25^\circ\text{C}/\text{W}$
 $\theta_{JA} = 60^\circ\text{C}/\text{W}$

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Table 1.

Test	Symbol	Device	Design Limit @+25°C	Sub Group 1	Sub Group 2, 3	Test Condition ¹	Unit
Power Dissipation	P_D	-1	575	575	575	Three-States Outputs	mW max
Input Resistance	R_{IN}	-1	3	3		10 V Span	k Ω min
			7	7			k Ω max
			6	6		20 V Span	k Ω min
			14	14			k Ω max
Internal Reference Output Voltage ²	V_{REF}	-1	+9.9	+9.9		Bipolar 20 V Span 2.0 mA External Load	V min
			+10.1	+10.1			V max
Logic Input High Voltage CE, \overline{CS} , R/ \overline{C} , A_O	V_{IH}	-1	2.0	2.0	2.0		+V min
Logic Input Low Voltage CE, \overline{CS} , R/ \overline{C} , A_O	V_{IL}	-1	0.8	0.8	0.8		+V max
Logic Input Current CE, \overline{CS} , R/ \overline{C} , A_O	I_{LIN}	-1	10	10	10	$V_{IH} = 5.0$ V; $V_{IL} = 0.0$ V	$\pm\mu$ A max
Logic Output High Voltage DB11-DB0	V_{OH}	-1	2.4	2.4	2.4	$I_{SOURCE} = 500$ μ A	+V min
Logic Output Low Voltage DB11-DB0, STS	V_{OL}	-1	0.4	0.4	0.4	$I_{SINK} = 1.6$ mA	+V max
Three-State Output Leakage DB11-DB0	I_{OLT}	-1	10	10	10	Outputs Three-States $V_{IH} = 5.0$ V	$\pm\mu$ A max
Power Supply Current	I_L I_{CC} I_{EE}	-1	8	8	8	Outputs Three-States REF OUT to REF IN through 50 Ω	mA max
			14	14	14		
			18	18	18		
Integral Nonlinearity	INL	-1	1/2	1/2	1	Major Transitions Unipolar 10 V Span Bipolar 20 V Span	\pm LSB max
Differential Nonlinearity ³	DNL	-1	12	12	12	All Codes Tested Unipolar 10 V Span Bipolar 20 V Span	Bits min
Power Supply Rejection ⁴	PSR	-1	1	1	1	See Note 5 Unipolar—10 V Span	\pm LSB max
			1/2	1/2	1/2	See Note 6	
			1	1	1	See Note 7	
Unipolar Offset Error	V_{OSE}	-1	2	2		10 V Span	\pm LSB max
Unipolar Offset Drift	TC_{VOS}	-1			1	10 V Span	\pm LSB max
Bipolar Offset Error	B_{POE}	-1	3	3		20 V Span	\pm LSB max
Bipolar Offset Drift	TCB_{POE}	-1			2	20 V Span	\pm LSB max
Full-Scale Calibration Error	A_B	-1	0.125	0.125		Bipolar 20 V Span	\pm % of FSR max
	A_U	-1	0.125			Unipolar 10 V Span	
Full-Scale Calibration Drift	TCA_E	-1			7	Bipolar 20 V Span	\pm LSB max

Test	Symbol	Device	Design Limit @+25°C	Sub Group 4	Sub Group 5, 6	Test Condition ¹	Unit
Signal to Noise and Distortion	S/(N+D)	-1	70	70	70	$f_{IN} = 10 \text{ kHz}, f_{SAMPLE} = 100 \text{ kSPS}$	dB min
Total Harmonic Distortion	THD	-1	-82	-82	-82	$f_{IN} = 10 \text{ kHz}, f_{SAMPLE} = 100 \text{ kSPS}$	dB max
Peak Spurious or Harmonic Component		-1	-82	-82	-82	$f_{IN} = 10 \text{ kHz}, f_{SAMPLE} = 100 \text{ kSPS}$	dB max
Intermodulation Distortion ⁸	IMD	-1	-80	-80	-80	Second Order Products	dB max
			-80	-80	-80	Third Order Products	

Test	Symbol	Device	Design Limit @+25°C	Sub Group 9	Sub Group 10, 11	Test Condition ¹	Unit
Converter Start Timing Conversion Time	t_C	-1	8	8	8	To 8-Bits	$\mu\text{s max}$
STS Delay from CE	t_{DSC}	-1	10	10	10	To 12-Bits	$\mu\text{s max}$
CE Pulse Width	t_{HEC}	-1	200	200	225	Timing per Figure 1	ns max
\overline{CS} to CE Setup	t_{SSC}	-1	50	50	50	Timing per Figure 1	ns min
\overline{CS} Low During CE High	t_{HSC}	-1	50	50	50	Timing per Figure 1	ns min
R/C to CE Setup	t_{SRC}	-1	50	50	50	Timing per Figure 1	ns min
R/C Low During CE High	t_{HRC}	-1	50	50	50	Timing per Figure 1	ns min
A_0 to CE Setup	t_{SAC}	-1	0	0	0	Timing per Figure 1	ns min
A_0 Valid During CE High	t_{HAC}	-1	50	50	50	Timing per Figure 1	ns min
Read Timing-Full Control Mode Access Time	t_{DD}	-1	150	150	150	Load per Figure 3 and Table 2	ns max
Data Valid After CE Low	t_{HD}	-1	25	25	15	Timing per Figure 2	ns min
Output Float Delay	t_{HL}	-1	150	150	150	Load per Figure 3 and Table 2	ns max
\overline{CS} to CE Setup	t_{SSR}	-1	50	50	50	Timing per Figure 2	ns min
R/C to CE Setup	t_{SRR}	-1	0	0	0	Timing per Figure 2	ns min
A_0 to CE Setup	t_{SAR}	-1	50	50	50	Timing per Figure 2	ns min
\overline{CS} Valid After CE Low	t_{HSR}	-1	0	0	0	Timing per Figure 2	ns min
R/C High After CE Low	t_{HRR}	-1	0	0	0	Timing per Figure 2	ns min
A_0 Valid After CE Low	t_{HAR}	-1	50	50	50	Timing per Figure 2	ns min
Read Timing-Stand-Alone Mode Data Access Time	t_{DDR}	-1	150	150	150	Timing per Figures 4a and 4b	ns max
Low R/C Pulse Width	t_{HRL}	-1	50	50	50	Timing per Figures 4a and 4b	ns min
STS Delay from R/C	t_{DS}	-1	200	200	225	Timing per Figures 4a and 4b	ns max
Data Valid After R/C Low	t_{HDR}	-1	25	25	25	Timing per Figures 4a and 4b	ns min
STS Delay After Data Valid	t_{HS}	-1	0.6	0.6	0.6	Timing per Figures 4a and 4b	$\mu\text{s min}$
High R/C Pulse Width	t_{HRH}	-1	1.2	1.2	1.2	Timing per Figures 4a and 4b	$\mu\text{s max}$
			150	150	150	Timing per Figures 4a and 4b	ns min

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NOTES

¹ T_{MIN} to T_{MAX} ; $V_{CC} = +15 \text{ V} \pm 10\%$ or $+12 \text{ V} \pm 5\%$; $V_{LOGIC} = +5 \text{ V} \pm 10\%$; $V_{EE} = -15 \text{ V} \pm 10\%$ or $-12 \text{ V} \pm 5\%$ unless otherwise specified; $12/\overline{8}$ connected to V_{LOGIC} ; A_0 and \overline{CS} at Logic "0," CE at Logic "1."

²10 V Unipolar—50 Ω resistor Pin 8 to Pin 10, 50 Ω resistor Pin 12 to ground. Analog input connected to Pin 13.

³20 V Bipolar—50 Ω resistor Pin 8 to Pin 12, 50 Ω resistor Pin 8 to Pin 10. Analog input connected to Pin 14.

See Figures 1, 2, 3 and 4 for timing information.

⁴The reference should be buffered for operation on $\pm 12 \text{ V}$ supplies.

⁵Minimum resolution for which no missing codes are guaranteed.

⁶Change in the full-scale unipolar 10 V span as power supply voltage is varied from min to max specified value.

⁷Test conditions for PSRR: $13.5 \text{ V} \leq V_{CC} \leq 16.5 \text{ V}$; $V_{LOGIC} = 5 \text{ V}$; $V_{EE} = -15 \text{ V}$; $11.4 \text{ V} \leq V_{CC} \leq 12.6 \text{ V}$; $V_{LOGIC} = 5 \text{ V}$; $V_{EE} = -12 \text{ V}$.

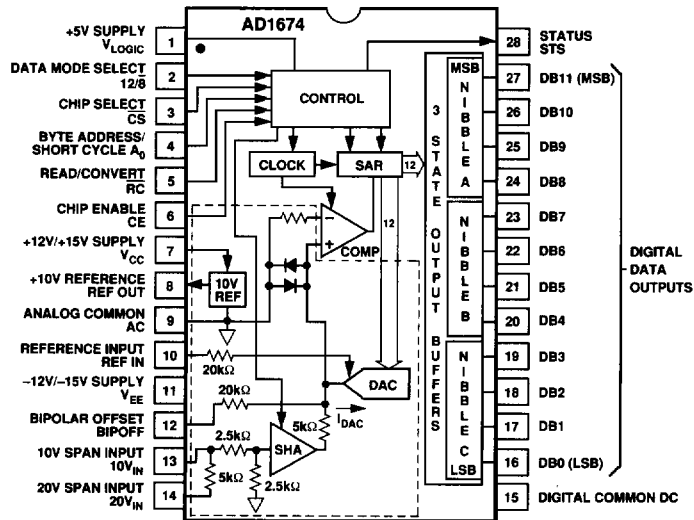
⁸ $4.5 \text{ V} \leq V_{LOGIC} \leq 5.5 \text{ V}$; $V_{CC} = 15 \text{ V}$; $V_{EE} = -15 \text{ V}$.

⁹ $-16.5 \text{ V} \leq V_{EE} \leq -13.5 \text{ V}$; $V_{LOGIC} = 5 \text{ V}$; $V_{CC} = 15 \text{ V}$; $-12.6 \text{ V} \leq V_{EE} \leq -11.4 \text{ V}$; $V_{LOGIC} = 5 \text{ V}$; $V_{CC} = 12 \text{ V}$.

¹⁰ $f_a = 9.08 \text{ kHz}$; $f_b = 9.58 \text{ kHz}$ with $f_{SAMPLE} = 100 \text{ kHz}$.

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3.2.1 Functional Block Diagram and Terminal Assignments.

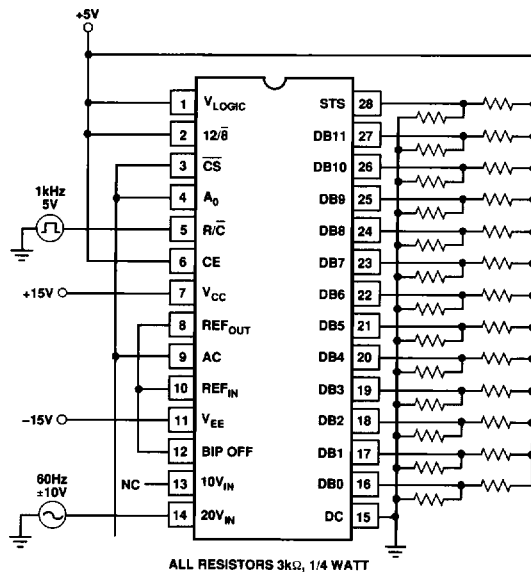


3.2.4 Microcircuit Technology Group.

This microcircuit is covered by technology group (57).

4.2.1 Life Test/Burn-In Circuit.

Steady state life test is per MIL-STD-883 Method 1005. Burn-in is per MIL-STD-883 Method 1015 Test Condition (B).



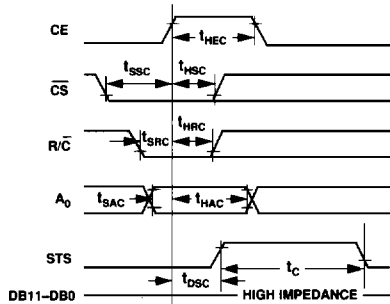


Figure 1. Converter Start Timing

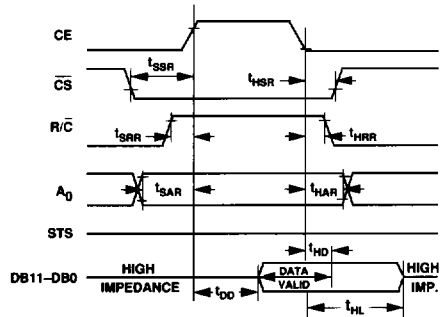


Figure 2. Read Timing

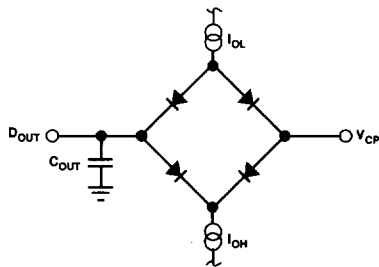


Figure 3. Load Circuit for Bus Timing Specifications

Table 2. Load Conditions for Bus Timing Specifications

Test	V _{CP}	C _{OUT}
Access Time High Z to Logic Low	5 V	100 pF
Float Time Logic High to High Z	0 V	10 pF
Access Time High Z to Logic High	0 V	100 pF
Float Time Logic Low to High Z	5 V	10 pF

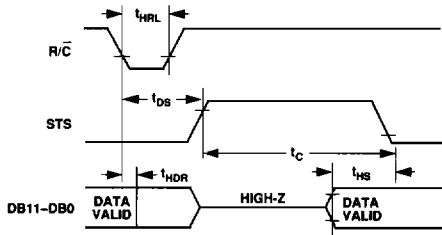


Figure 4a. Stand-Alone Mode Timing Low Pulse for R/C

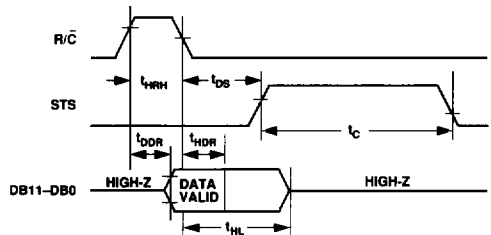


Figure 4b. Stand-Alone Mode Timing High Pulse for R/C

Table 3. AD1674 Truth Table

CE	CS	R/C	12/8	A ₀	Operation
0	X	X	X	X	None
X	1	X	X	X	None
1	0	0	X	0	Initiate 12-Bit Conversion
1	0	0	X	1	Initiate 8-Bit Conversion
1	0	1	1	X	Enable 12-Bit Parallel Output
1	0	1	0	0	Enable 8 Most Significant Bits
1	0	1	0	1	Enable 4 LSBs and 4 Trailing Zeros